

- Four Analog Inputs, Four BTL Power Outputs
- Typical Output Power at 10% THD+N
  - 28 W/Ch Into 4 at 14.4 V
  - 50 W/Ch Into 2 at 14.4 V
  - 79 W/Ch Into 4 at 24 V
- Patented Pop- and Click-Reduction
- Heat Slug Up for the TAS5424B-Q1
- 44-Pin PSOP3 (DKE) Low-Standoff Power SOP Package With Heat Slug Up for the TAS5424B-Q1
- 64-Pin QFP (PHD) Power Package With Heat

#### Technology

- Soft Muting With Gain Ramp Control
- Common-Mode Ramping

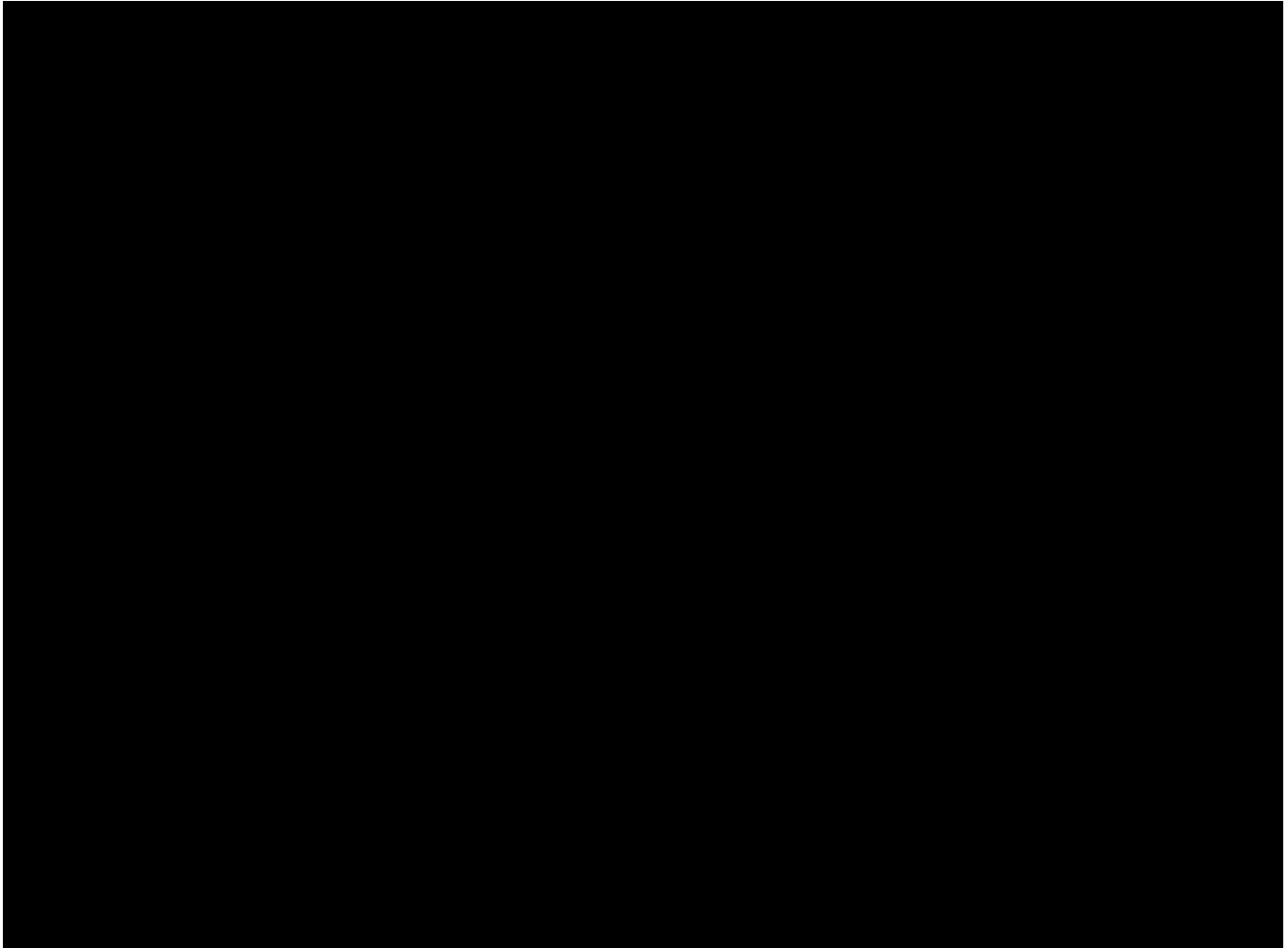
#### APPLICATIONS

- OEM/Retail Head Units and Amplifier Modules Where Feature Densities and



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

## FUNCTIONAL BLOCK DIAGRAM





1  
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3  
4  
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16

19 20





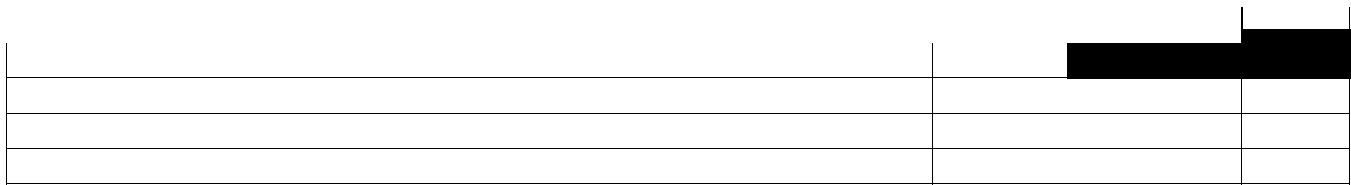




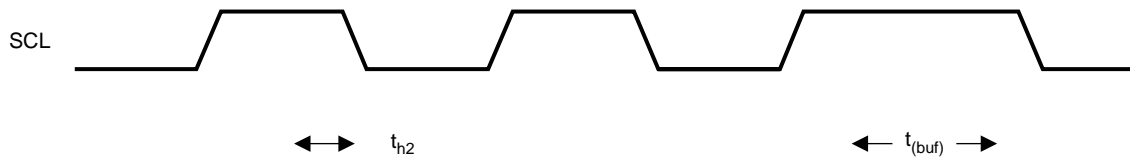








SCL

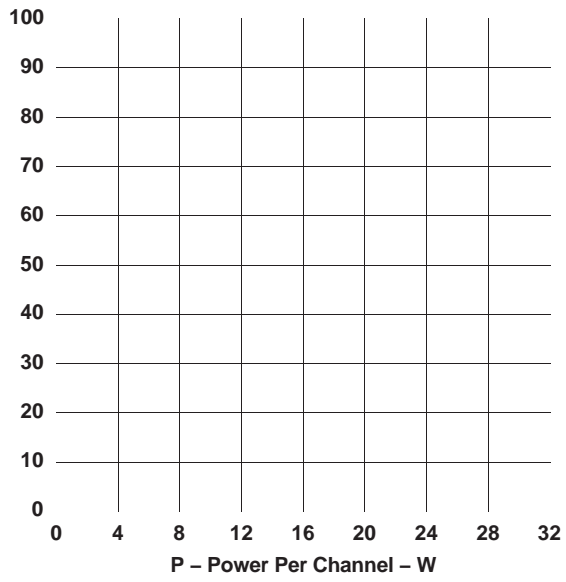
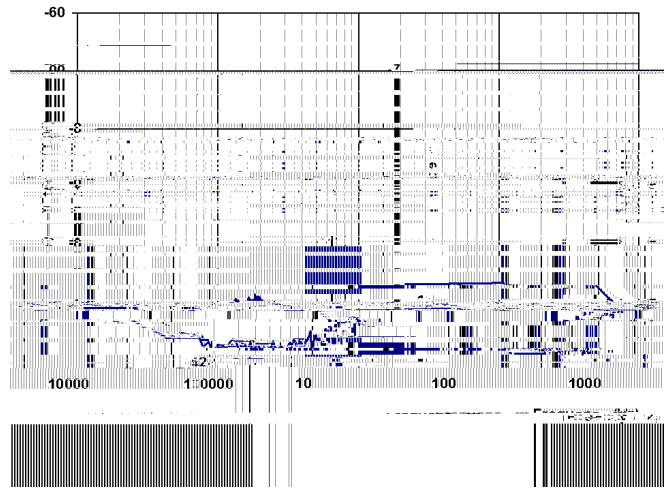


SDA





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## DESCRIPTION OF OPERATION

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### I<sup>2</sup>C Serial Communication Bus

The device communicates with the system processor via the I<sup>2</sup>C serial communication bus as an I<sup>2</sup>C slave-only device. The processor can poll the device


transmits the next byte of the sequence. Each device is addressed by a unique 7-bit slave address plus R/W bit (1 byte). All compatible devices share the same signals via a bidirectional bus using a wired-AND connection. An external pullup resistor must be used for the SDA and SCL signals to set the HIGH level for the bus. There is no limit on the number of bytes that can be transmitted between start and stop conditions. When the last word transfers, the master generates a stop condition to release the bus.

### Figure 13. Typical I<sup>2</sup>C Sequence

Use the I2C\_ADDR pin (pin 2) to program the device for one of four addresses. These four addresses are licensed I<sup>2</sup>C addresses and do not conflict with other licensed I<sup>2</sup>C audio devices. To communicate

TAS54168AND the





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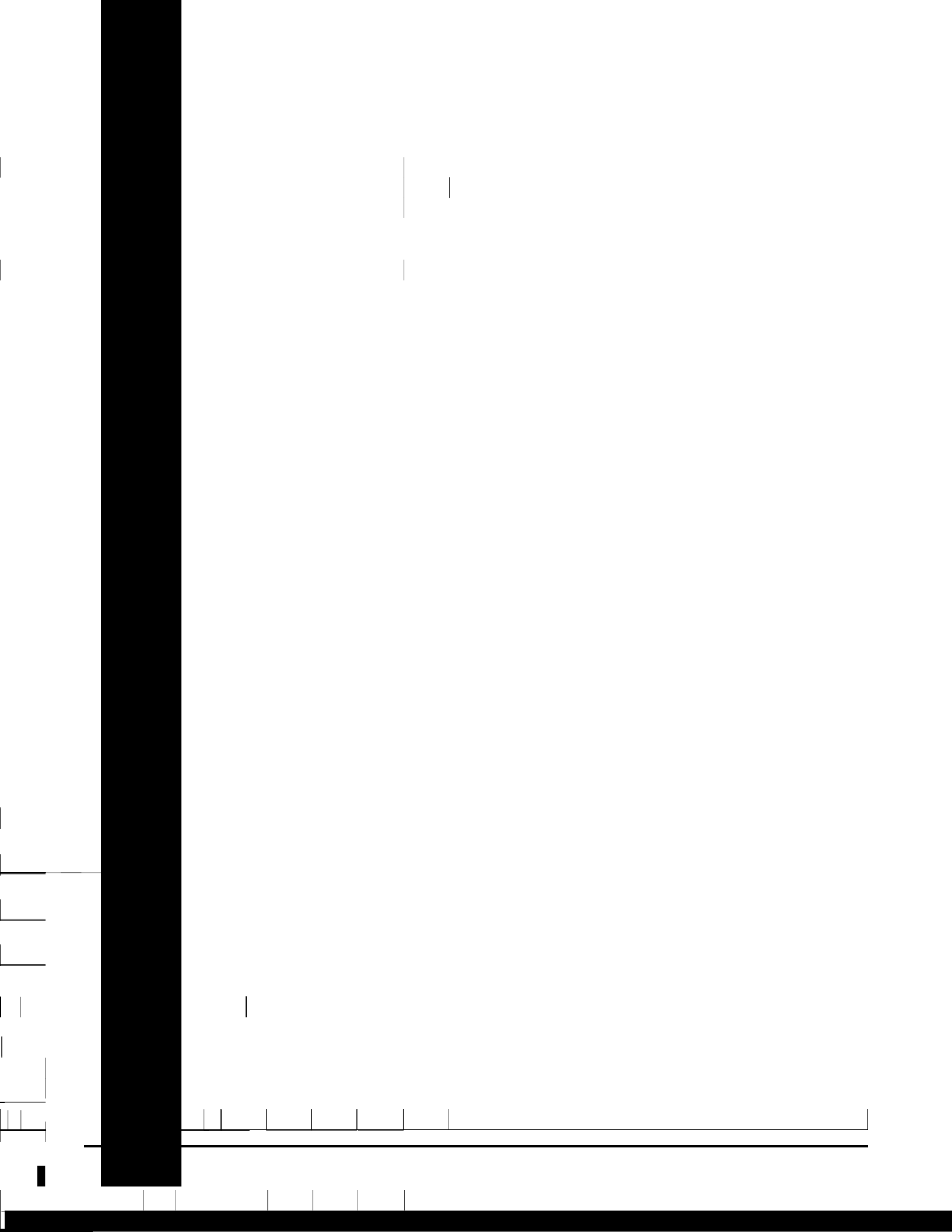
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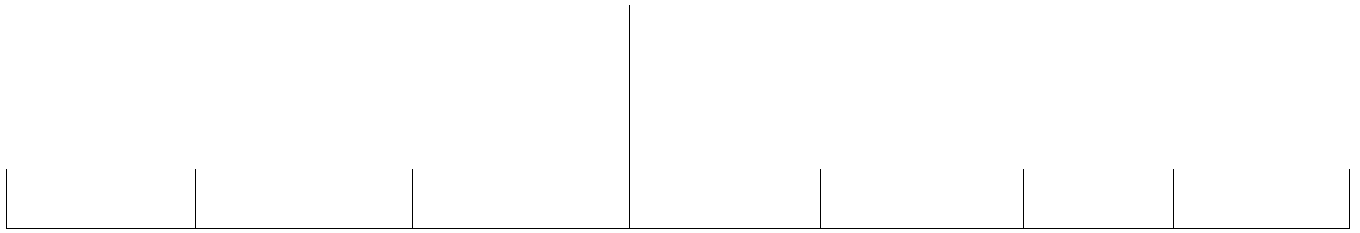
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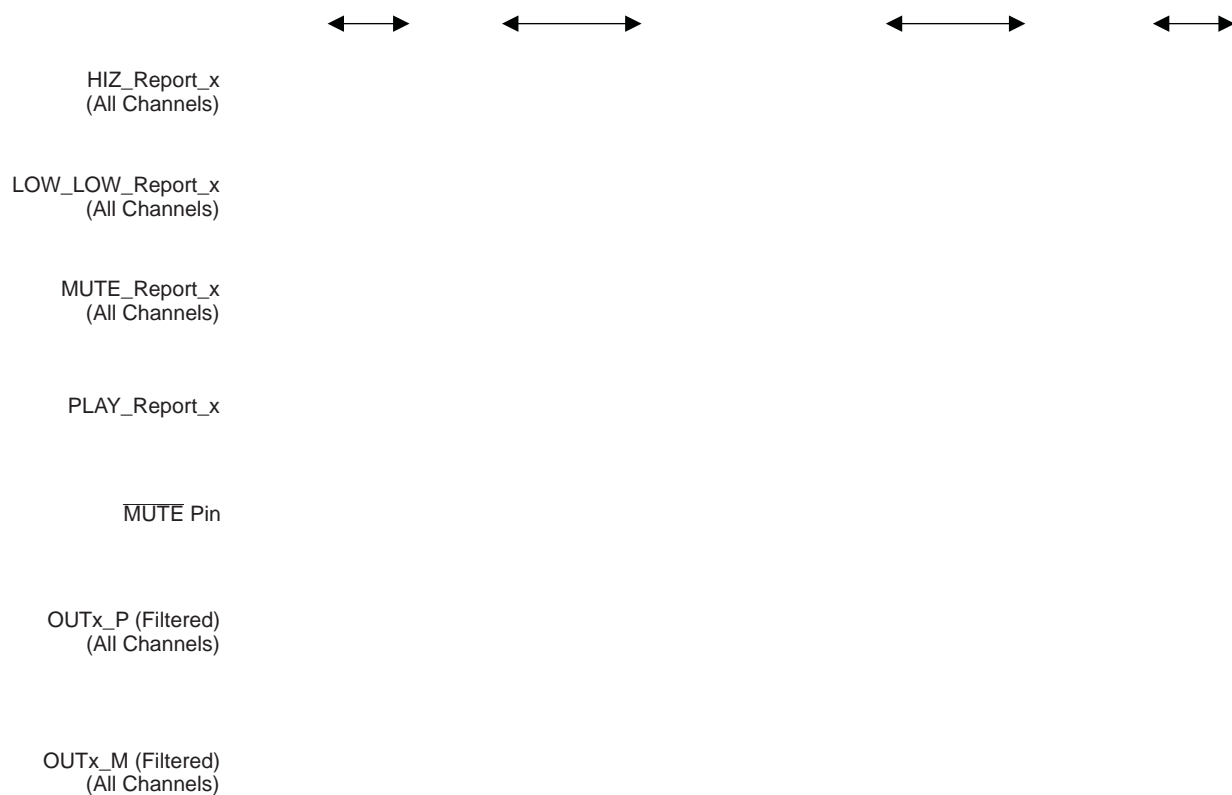
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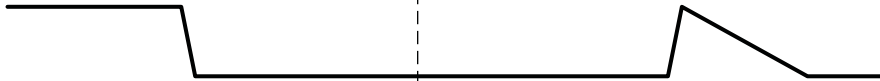
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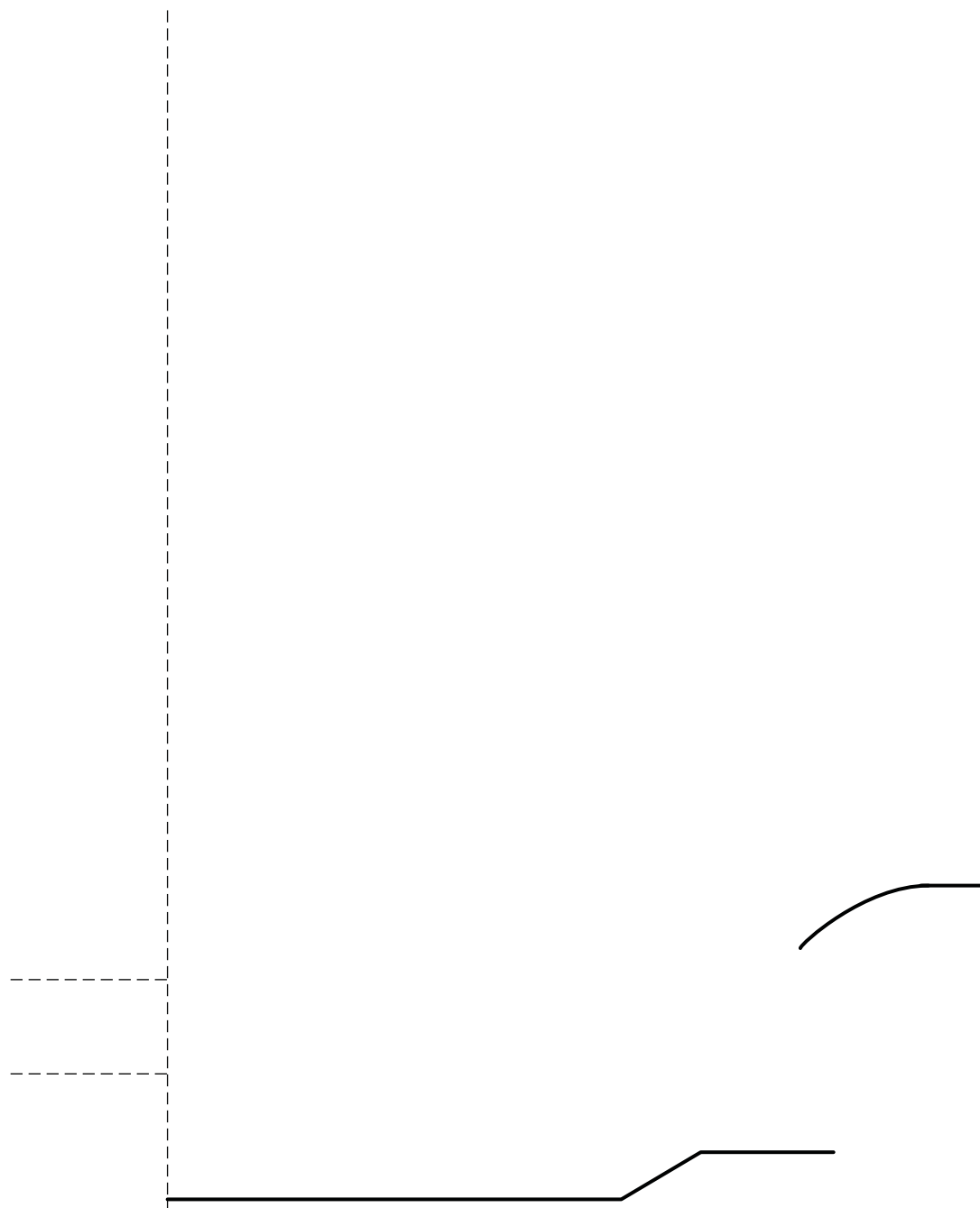


**Figure 18. Click- and Pop-Free Shutdown and Restart Sequence Timing Diagram**

HIZ\_x  
MUTE\_Report

MUTE Pin





**Figure 20. Latched Global Fault Shutdown and Individual Channel Restart Timing Diagram (UV Shutdown and Recovery)**

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# TAS5414B-Q1 TAS5424B-Q1

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performance and even power dissipation on multiple channels. For smooth power up, power down, and mute operation, the same control commands (such as mute, play, Hi-Z, etc.) should be sent to the paralleled channels at the same time. Load diagnostic is also supported for parallel connection. Paralleling on the device side of the LC output filter is not supported, and can result in device failure.



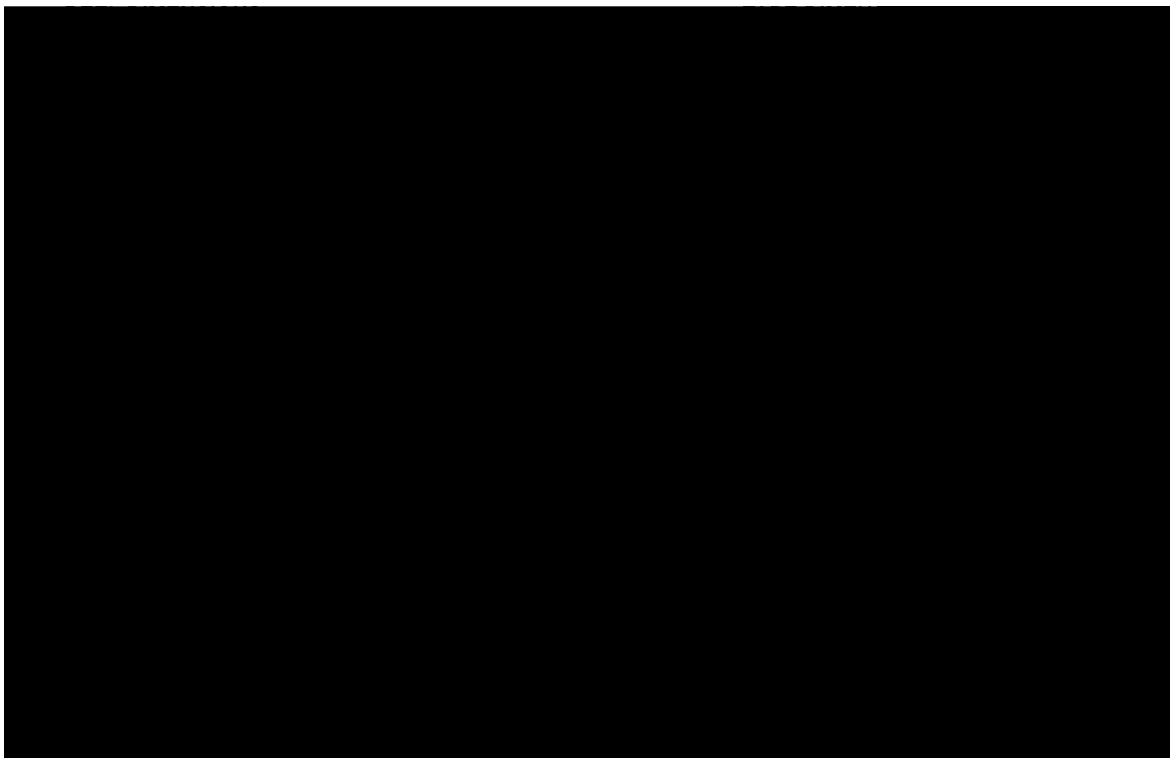
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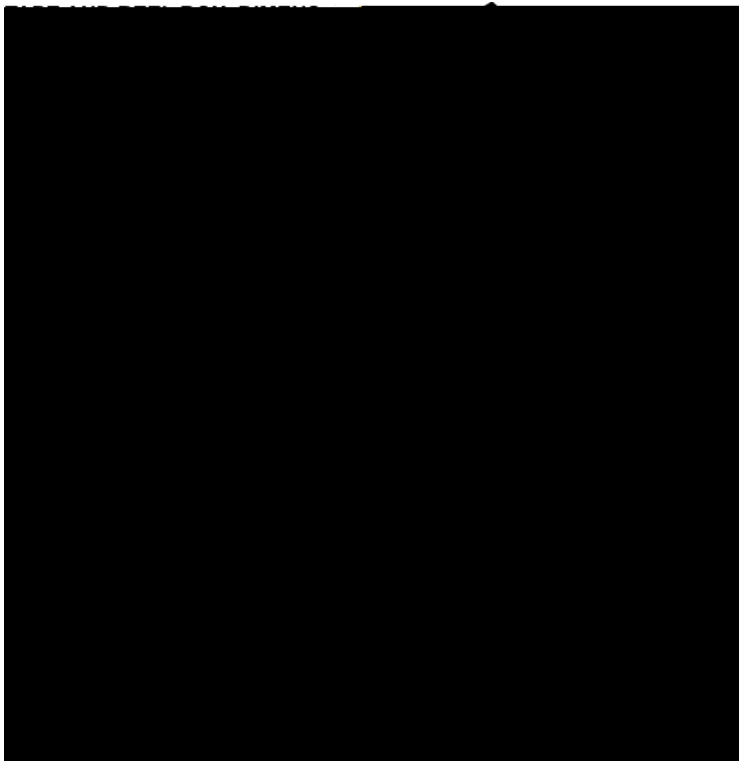


## TAPE AND REEL INFORMATION



\*All dimensions are nominal

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\*All dimensions are nominal

Device
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# PACKAGE OUTLINE

C ◀

0.35  
GAGE PLANE



▶ 1.1  
0.8

# EXAMPLE BOARD LAYOUT

36X (2) ◀



(13.2)



0.05 MAX  
AROUND



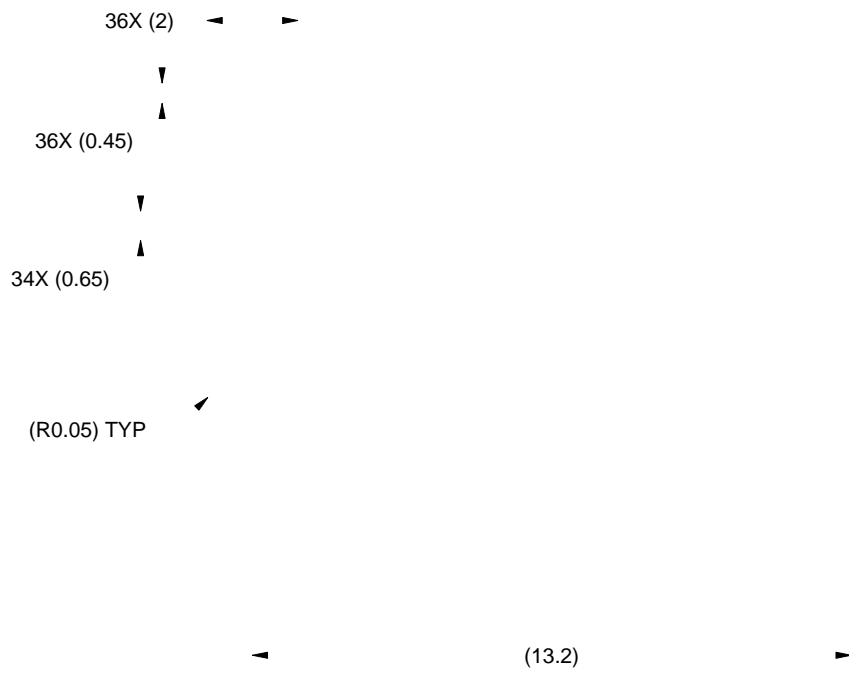
0.05 MIN  
AROUND



# EXAMPLE STENCIL DESIGN

DKD0036A

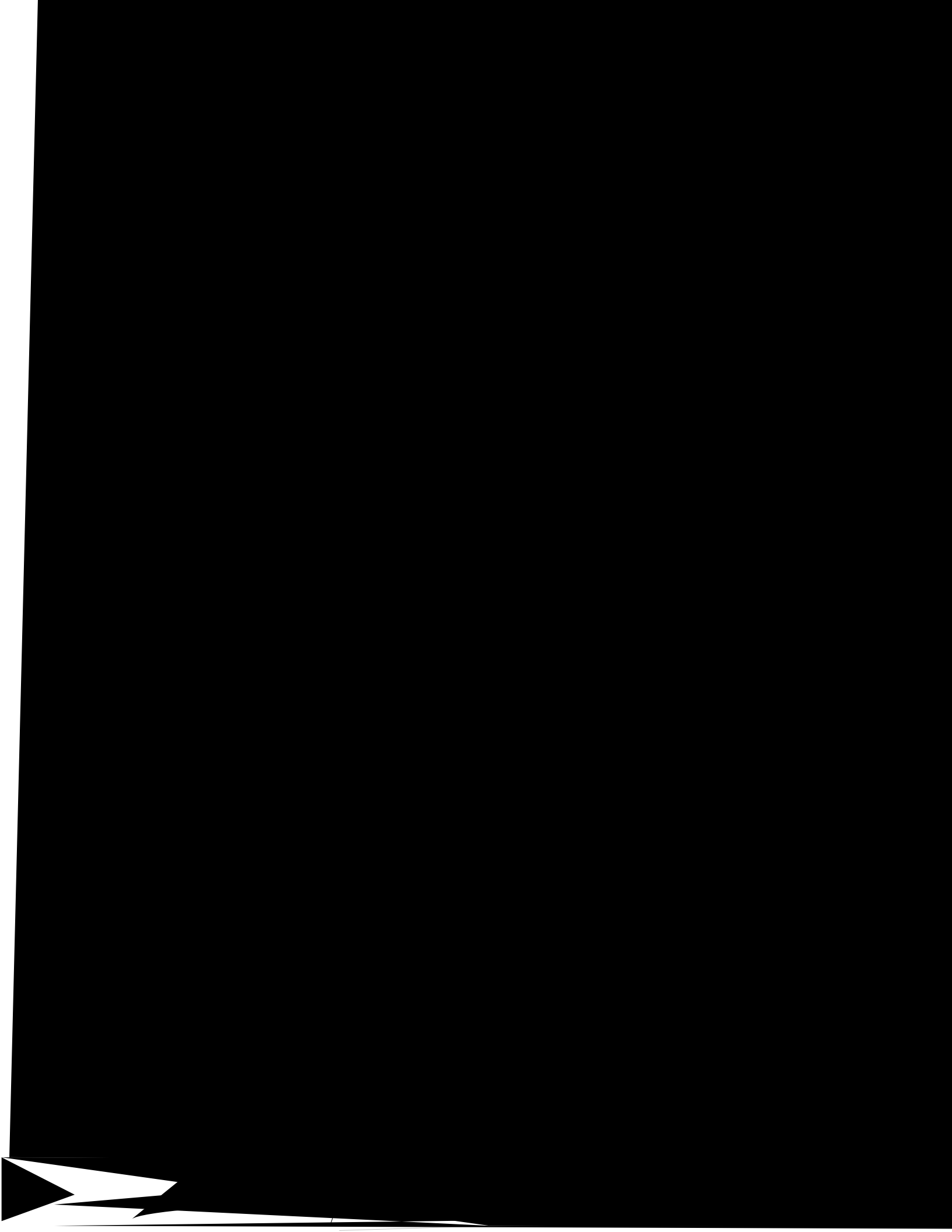
PowerPAD SSOP - 3.6 mm max height



PowerPAD PLA







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